Application/Control No. Applicant(s)/Patent Under Reexamination 10/613,407 REESE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2625 Houshang Safaipour **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY US-2003/0203744 10-2003 Otsuka, Naoki 455/551 Α US-2003/0048484 03-2003 Seki et al. В 358/402 US-2005/0144562 06-2005 С Schena et al. 715/741 US-D US-Ε US-F US-G US-Н US-١ US-J US-Κ US-L US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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